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## **AON7544**

### 30V N-Channel AlphaMOS

### **General Description**

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low RDS(on) at 4.5V<sub>GS</sub>
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### **Product Summary**

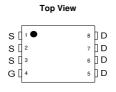
 $V_{\text{DS}} \\$ 30V  $I_D$  (at  $V_{GS}=10V$ ) 30A  $R_{DS(ON)}$  (at  $V_{GS}$ =10V) < 5m $\Omega$  $R_{DS(ON)}$  (at  $V_{GS} = 4.5V$ )  $< 8.5 \text{m}\Omega$ 

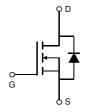
100% UIS Tested 100% R<sub>g</sub> Tested



- **Application**DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial







Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted							
Parameter		Symbol	Maximum	Units			
Drain-Source Voltage		$V_{DS}$	30	V			
Gate-Source Voltage		V <sub>GS</sub>	±20	V			
Continuous Drain	T <sub>C</sub> =25℃	L	30				
Current <sup>G</sup>	T <sub>C</sub> =100℃	I <sub>D</sub>	23	A			
Pulsed Drain Current C		I <sub>DM</sub>	120				
Continuous Drain	T <sub>A</sub> =25℃		20	A			
Current	T <sub>A</sub> =70℃	IDSM	16	$\neg$			
Avalanche Current <sup>C</sup>		I <sub>AS</sub>	32	A			
Avalanche energy L=0.05mH <sup>C</sup>		E <sub>AS</sub>	26	mJ			
V <sub>DS</sub> Spike	100ns	V <sub>SPIKE</sub>	36	V			
	T <sub>C</sub> =25℃		23	W			
Power Dissipation <sup>B</sup>	T <sub>C</sub> =100℃	$-P_{D}$	9	VV			
	T <sub>A</sub> =25℃	D	3	W			
Power Dissipation <sup>A</sup> T <sub>A</sub> =70℃		P <sub>DSM</sub>	2	VV			
Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to 150	C			

Thermal Characteristics							
Parameter	Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	30	40	°C/W		
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	60	75	℃/W		
Maximum Junction-to-Case Steady-S		R <sub>eJC</sub>	4.5	5.4	℃/W		



#### Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		30			V			
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS}$ =30V, $V_{GS}$ =0V				1				
	Zero Gate Voltage Brain Gurrent		T <sub>J</sub> =55℃			5	μΑ			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ = ±20V				100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=250\mu A$		1.2	1.8	2.2	V			
	Static Drain-Source On-Resistance	$V_{GS}=10V$ , $I_D=20A$			4.1	5	mΩ			
R <sub>DS(ON)</sub>			T <sub>J</sub> =125℃		5.6	6.8				
		$V_{GS}$ =4.5V, $I_D$ =20A			6.7	8.5	mΩ			
g <sub>FS</sub>	Forward Transconductance	$V_{DS}$ =5V, $I_{D}$ =20A			91		S			
$V_{SD}$	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$			0.7	1	V			
$I_S$	Maximum Body-Diode Continuous Current					28	Α			
DYNAMIC	PARAMETERS									
$C_{iss}$	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz			951		pF			
Coss	Output Capacitance				373		pF			
C <sub>rss</sub>	Reverse Transfer Capacitance				62		pF			
$R_g$	Gate resistance	$V_{GS}$ =0V, $V_{DS}$ =0V, f=1MHz			1.5		Ω			
SWITCHI	NG PARAMETERS									
$Q_g(10V)$	Total Gate Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A			15.7	22.5	nC			
$Q_g(4.5V)$	Total Gate Charge				7.5	10.5	nC			
$Q_{gs}$	Gate Source Charge				2.8		nC			
$Q_gd$	Gate Drain Charge				3.2		nC			
$t_{D(on)}$	Turn-On DelayTime				6.25		ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =15V, $R_{L}$ =0.75 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2.5		ns			
$t_{D(off)}$	Turn-Off DelayTime				18.5		ns			
t <sub>f</sub>	Turn-Off Fall Time				4		ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	$I_F$ =20A, dI/dt=500A/ $\mu$ s			10.2		ns			
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F$ =20A, dI/dt=500A/ $\mu$ s			13.6		nC			

A. The value of  $R_{\theta JA}$  is measured with the device mounted on  $1 in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25° C. The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of  $150^{\circ}\,$  C. The value in any given application depends on the user's specific board design.

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B. The power dissipation  $P_D$  is based on  $T_{J_{(MAX)}}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150° C.

D. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

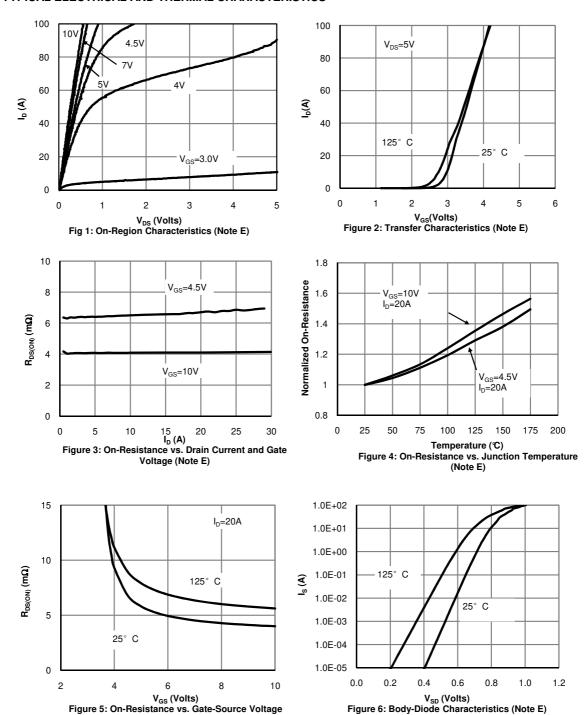
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}$  C.



#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

(Note E)





#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

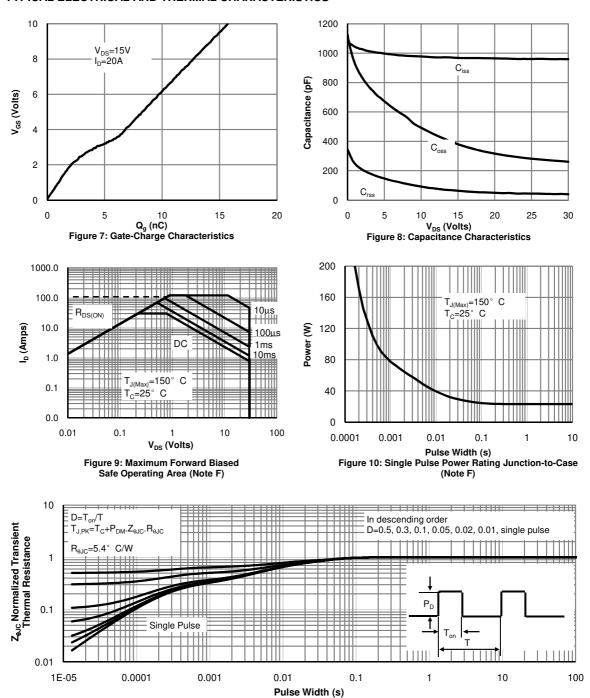
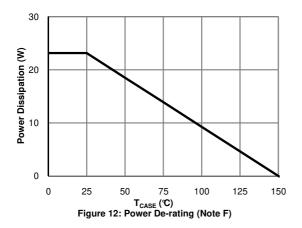
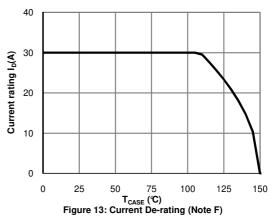


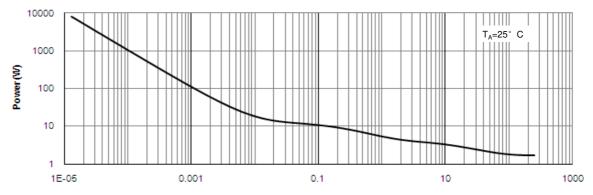
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



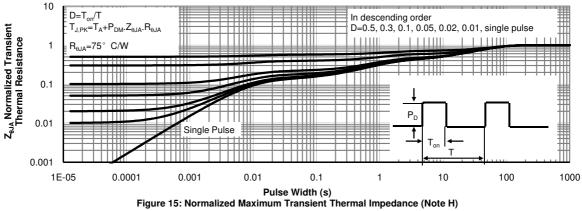
#### TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





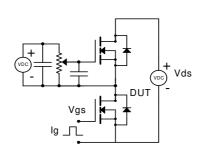


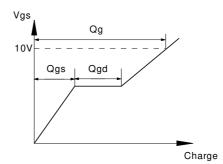
Pulse Width (s)
Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)



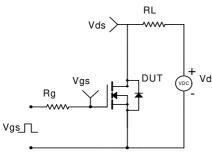


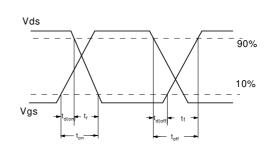
### Gate Charge Test Circuit & Waveform



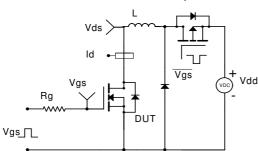


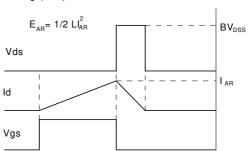
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

